

A geometrical setting for the classification of multilayers

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We elaborate on the consequences of the factorization of the transfer matrix of any lossless multilayer in terms of three basic matrices of simple interpretation. By considering the bilinear transformation that this transfer matrix induces in the complex plane, we introduce the concept of multilayer transfer function and study its properties in the unit disk. In this geometrical setting, our factorization translates into three actions that can be viewed as the basic pieces for understanding the multilayer behavior. Additionally, we introduce a simple trace criterion that allows us to classify multilayers in three types with properties closely related to one (and only one) of these three basic matrices. We apply this approach to analyze some practical examples that are typical representatives of these types of matrices.

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I. INTRODUCTION

Layered media play an important role in many applications in modern optics, especially in relation to optical filters and the like. Therefore, it is not surprising that the topics covered in most of the textbooks on the subject use a mixture of design, manufacture, and applications; dealing only with the basic physics needed to carry out practical computations [1].

However, for a variety of reasons, layered media have physical relevance on their own [2, 3]. As any linear system with two input and two output channels, any multilayer can be described in terms of a 2×2 transfer matrix. In fact, it has been recently established that for a lossless multilayer this transfer matrix is an element of the group $SU(1,1)$ [4, 5]. From this perspective, it is precisely the abstract composition law of $SU(1,1)$ the ultimate responsible for the curious composition law of the reflection and transmission coefficients [6, 7].

This purely algebraic result is certainly remarkable. But, as soon as one realizes that $SU(1,1)$ is also the basic group of the hyperbolic geometry [8], it is tempting to look for an enriching geometrical interpretation of the multilayer action. Moreover, given the role played by geometrical ideas in all branches of physics, particularly in special relativity, it is easy to convince oneself that this approach might provide deeper insights into the behavior of a multilayer in a wider unifying framework that can put forward fruitful analogies with other physical phenomena.

Accordingly, we have proposed [9] to view the action of any lossless multilayer as a bilinear transformation on the unit disk, obtained by stereographic projection of the unit hyperboloid of $SU(1,1)$. This kind of bilinear representations have been discussed in detail for the Poincaré sphere in polarization optics [10, 11], for Gaussian beam propagation [12], and are also useful in laser mode-locking and optical pulse transmission [13].

In spite of these achievements, the action of an arbitrary lossless stack could still become cumbersome to interpret in physical terms. In fact, in practice it is usual to work directly with the numerical values of a matrix obtained from the experiment, which cannot be directly related to the inner multilayer structure. To remedy this situation, we have resorted recently [14] to the Iwasawa decomposition, which provides a remarkable factorization of the matrix representing any multilayer (no matter how complicated it could be) as the product of three matrices of simple interpretation.

At the geometrical level, such a decomposition translates directly into the classification of three basic actions in the unit disk, which are studied in this paper, that can be considered as the basic bricks for understanding multilayers. Moreover, we have also shown [15] that the trace of the transfer matrix allows for a classification of multilayers in three different types with properties very close to those appearing in the Iwasawa decomposition.

In this paper we go one step further and exploit this new classification to study several practical examples that are representatives of each type. This shows the power of the method and, at the same time, allows for a deeper understanding of layered media. As a direct application, we treat the outstanding case of symmetric multilayers, finding a precise criterion for zero-reflectance conditions. Nevertheless, we stress that the benefit of this formulation lies not in any inherent advantage in terms of efficiency in solving problems in layered structures. Rather, we expect that the formalism presented here could provide a general and unifying tool to analyze multilayer performance in an elegant and concise way that, additionally, is closely related to other fields of physics, which seems to be more than a curiosity.

II. TRANSFER MATRIX FOR A LOSSLESS MULTILAYER

We first briefly summarize the essential ingredients of multilayer optics we shall need for our purposes [10]. The configuration is a stratified structure, illustrated in Fig. 1, that consists of a stack of $1, \dots, j, \dots, m$, plane-parallel lossless layers sandwiched between two semi-infinite ambient (a) and substrate (s) media, which we shall assume to be identical, since this is the common experimental case. Hereafter all the media are supposed to be lossless, linear, homogeneous, and isotropic.

We consider an incident monochromatic linearly polarized plane wave from the ambient, which makes an angle θ_0 with the normal to the first interface and has amplitude $E_a^{(+)}$. The electric field is either in the plane of incidence (p polarization) or perpendicular to the plane of incidence (s polarization). We consider as well another plane wave of the same frequency and polarization, and with amplitude $E_s^{(-)}$, incident from the substrate at the same angle θ_0 . [16]

As a result of multiple reflections in all the interfaces, we have a backward-traveling plane wave in the ambient, denoted $E_a^{(-)}$, and a forward-traveling plane wave in the substrate, denoted $E_s^{(+)}$. If we take the field amplitudes as a vector of the form

$$\mathbf{E} = \begin{pmatrix} E^{(+)} \\ E^{(-)} \end{pmatrix}, \quad (1)$$

which applies to both ambient and substrate media, then the amplitudes at each side of the multilayer are related by the 2×2 complex matrix $\mathbf{M}_{as}$, we shall call the multilayer transfer matrix, [17] in the form

$$\mathbf{E}_a = \mathbf{M}_{as} \mathbf{E}_s. \quad (2)$$

The matrix $\mathbf{M}_{as}$ can be shown to be of the form [6]

$$\mathbf{M}_{as} = \begin{bmatrix} 1/T_{as} & R_{as}^*/T_{as}^* \\ R_{as}/T_{as} & 1/T_{as}^* \end{bmatrix} \equiv \begin{bmatrix} \alpha & \beta \\ \beta^* & \alpha^* \end{bmatrix}, \quad (3)$$

where the complex numbers

$$R_{as} = |R_{as}| \exp(i\rho), \quad T_{as} = |T_{as}| \exp(i\tau), \quad (4)$$

are, respectively, the overall reflection and transmission coefficients for a wave incident from the ambient. Note that we have $\det \mathbf{M}_{as} = +1$, which is equivalent to $|R_{as}|^2 + |T_{as}|^2 = 1$, and then the set of lossless multilayer matrices reduces to the group $SU(1,1)$, whose elements depend on three independent real parameters.

The identity matrix corresponds to $T_{as} = 1$ and $R_{as} = 0$, so it represents an antireflection system without transmission phase shift. The matrix that describe the overall system obtained by putting two multilayers together is the product of the matrices representing each one of them, taken in the appropriate order. So, two multilayers, which are inverse, when composed give an antireflection system.

If we denote by R_{sa} and T_{sa} the overall reflection and transmission coefficients for a wave incident from the substrate (physically this corresponds to the same multilayer taken in the reverse order) one can check that [4]

$$T_{as}T_{sa} - R_{as}R_{sa} = \exp(i2\tau), \quad (5)$$

$$R_{sa} = -R_{as}^* \exp(i2\tau),$$

which is a generalization of the well-known Stokes relations [3] for the overall stack.

On the other hand, it is worth noting that, while the picture of a multilayer taken in the reverse order is clear, at first sight it is not so easy to imagine the inverse of that multilayer. However, using Eqs. (5), one can obtain that

$$\mathbf{M}_{as}^{-1} = \mathbf{M}_{sa}^*, \quad (6)$$

which remedies this drawback.

III. A BASIC FACTORIZATION FOR MULTILAYERS: THE IWASAWA DECOMPOSITION

Many matrix factorizations have been considered in the literature [18, 19, 20], the goal of all of them being to decompose a matrix as a unique product of other matrices of simpler interpretation. Particularly, given the essential role played by the Iwasawa decomposition, both in fundamental studies and in applications to several fields (especially in optics), one is tempted to investigate also its role in multilayer optics.

Without embarking us in mathematical subtleties, the Iwasawa decomposition is established as follows [21]: any element of a (noncompact semi-simple) Lie group can be written as an ordered product of three elements, taken one each from a maximal compact subgroup $\mathbf{K}$, a maximal Abelian subgroup $\mathbf{A}$, and a maximal nilpotent subgroup $\mathbf{N}$. Furthermore, such a decomposition is global and unique.

For a lossless multilayer matrix $\mathbf{M}_{as} \in SU(1,1)$, the decomposition reads as [14]

$$\mathbf{M}_{as} = \mathbf{K}(\phi) \mathbf{A}(\xi) \mathbf{N}(\nu), \quad (7)$$

where

$$\begin{aligned} \mathbf{K}(\phi) &= \begin{bmatrix} \exp(i\phi/2) & 0 \\ 0 & \exp(-i\phi/2) \end{bmatrix}, \\ \mathbf{A}(\xi) &= \begin{bmatrix} \cosh(\xi/2) & i \sinh(\xi/2) \\ -i \sinh(\xi/2) & \cosh(\xi/2) \end{bmatrix}, \\ \mathbf{N}(\nu) &= \begin{bmatrix} 1 - i\nu/2 & \nu/2 \\ \nu/2 & 1 + i\nu/2 \end{bmatrix}. \end{aligned} \quad (8)$$

The parameters ϕ, ξ , and ν are given in terms of the elements of the multilayer matrix by

$$\phi/2 = \arg(\alpha + i\beta),$$

$$\begin{aligned}\xi/2 &= \ln(1/|\alpha + i\beta|), \\ \nu/2 &= \operatorname{Re}(\alpha\beta^*)/|\alpha + i\beta|^2,\end{aligned}\quad (9)$$

and their ranges are $\xi, \nu \in \mathbb{R}$ and $-2\pi \leq \phi \leq 2\pi$. Therefore, given *a priori* limits on α and β (i.e., on T_{as} and R_{as}), one could easily establish the corresponding limits on ϕ , ξ and ν , and vice versa.

Now, we can interpret the physical action of the matrices appearing in Eq. (7). $\mathbf{K}(\phi)$ represents the free propagation of the fields $\mathbf{E}$ in the ambient medium through an optical phase thickness of $\phi/2$, which reduces to a mere shift of the origin of phases. Alternatively, this can be seen as an antireflection system. The second matrix $\mathbf{A}(\xi)$ represents a symmetric multilayer with real transmission coefficient $T_A = \operatorname{sech}(\xi/2)$ and reflection phase shift $\rho_A = \pm\pi/2$. There are many ways to get this performance, perhaps the simplest one is a Fabry-Perot system composed by two identical plates separated by a transparent spacer. By adjusting the refractive indices and the thicknesses of the media one can always get the desired values (see Section 7). Finally, the third matrix, $\mathbf{N}(\nu)$, represents a system having $T_N = \cos(\tau_N) \exp(i\tau_N)$ and $R_N = \sin(\tau_N) \exp(i\tau_N)$, with $\tan(\tau_N) = \nu/2$. The simplest way to accomplish this task is by an asymmetrical two-layer system.

IV. A REMARKABLE CASE: SYMMETRIC MULTILAYERS

So far, we have discussed various properties of arbitrary lossless multilayers. However, the particular case of symmetric structures has deserved a lot of attention. In this Section, we wish to show how the Iwasawa decomposition provides a nice tool to deal with them.

We recall that for a symmetric stack the reflection and transmission coefficients are the same whether light is incident on one side or on the opposite side of the multilayer. In consequence, one has $R_{as} = R_{sa}$ and the generalized Stokes relations (5) give then the well-known result [22, 23, 24]

$$\rho - \tau = \pm\pi/2. \quad (10)$$

This implies that the element β in the transfer matrix (3) is a pure imaginary number. Therefore, the matrix $\mathbf{M}_{as}$ depends only on two real parameters, which translates into the fact that ϕ , ξ , and ν [see Eqs. (9)] are not independent. In fact, a straightforward calculation shows that they must fulfill the constraint

$$\nu = (e^\xi - 1) \tan(\phi/2); \quad (11)$$

and thus R_{as} can be written as

$$R_{as} = e^{-i\phi} \frac{\tanh(\xi/2) [\tan(\phi/2) - i]}{1 - i \tanh(\xi/2) \tan(\phi/2)}. \quad (12)$$

Particular care has been paid to the characterization of zero reflectance conditions for these symmetrical systems [25, 26]. Equation (12) allows us to express the loci

of zero R_{as} by the simple condition

$$\xi = 0, \quad (13)$$

which, by Eq. (11) implies $\nu = 0$ and imposes that in this case $\mathbf{M}_{as}$ reduces trivially to a matrix $\mathbf{K}(\phi)$.

The stability of these nonreflecting configurations has been studied by Lekner [26]. Indeed, by using a continuity argument, he has shown that “almost all partial reflectors with symmetric profiles which are close in parameter space to a profile which has reflectivity zeros, will also have reflectivity zeros”. We intend to show how our formalism allows for a more precise criterion.

To this end, let us assume a symmetric multilayer satisfying initially the condition (13). Now, suppose that some parameter(s) (refractive index, thickness, angle of incidence, ...), we shall generically denote by ℓ , is varied. Obviously, admissible variations must preserve the symmetry of the system.

The variation of ℓ induces changes in R_{as} , and so in ϕ and ξ . The new multilayer will have also zero R_{as} if the parameters satisfy $dR_{as}/d\ell = 0$; that is,

$$\frac{dR_{as}}{d\ell} = \frac{\partial R_{as}}{\partial \phi} \bigg|_{\xi=0} \frac{d\phi}{d\ell} + \frac{\partial R_{as}}{\partial \xi} \bigg|_{\xi=0} \frac{d\xi}{d\ell} = 0. \quad (14)$$

Using Eq. (12), one gets that $\partial R_{as}/\partial \phi|_{\xi=0}$ is identically zero, while $\partial R_{as}/\partial \xi|_{\xi=0}$ never vanishes. We conclude then that the condition we are looking for is

$$\frac{d\xi}{d\ell} = 0. \quad (15)$$

This result fully characterizes the partial reflectors invoked by Lekner, and can be of practical importance for the design of robust antireflection systems.

V. MULTILAYER TRANSFER FUNCTION IN THE UNIT DISK

In many instances (e.g., in polarization optics [10]), we are interested in the transformation properties of quotients of variables rather than on the variables themselves. In consequence, it seems natural to consider the complex numbers

$$z = \frac{E^{(-)}}{E^{(+)}} \quad (16)$$

for both ambient and substrate. From a geometrical viewpoint, Eq. (2) defines a transformation of the complex plane $\mathbb{C}$, mapping the point z_s into the point z_a , according to

$$z_a = \Phi[\mathbf{M}_{as}, z_s] = \frac{\beta^* + \alpha^* z_s}{\alpha + \beta z_s}. \quad (17)$$

Thus, the action of the multilayer can be seen as a function $z_a = f(z_s)$ that can be appropriately called the multilayer transfer function [9]. The action of the inverse matrix $\mathbf{M}_{as}^{-1}$ is $z_s = \Phi[\mathbf{M}_{as}^{-1}, z_a]$.

These bilinear transformations define an action of the group $SU(1,1)$ on the complex plane $\mathbb{C}$. The complex plane appears then decomposed in three regions that remain invariant under the action of the group: the unit disk, its boundary and the external region. [27]

The Iwasawa decomposition has an immediate translation in this geometrical framework, and one is led to treat separately the action of each one of the matrices appearing in this decomposition. To this end, it is worth noting that the group $SU(1,1)$ that we are considering appears always as a group of transformations of the complex plane. The concept of orbit is especially appropriate for obtaining an intuitive picture of the corresponding action. We recall that, given a point z , its orbit is the set of points z' obtained from z by the action of all the elements of the group. In Fig. 2 we have plotted some typical orbits for each one of the subgroups of matrices $K(\phi)$, $A(\xi)$, and $N(\nu)$. For matrices $K(\phi)$ the orbits are circumferences centered at the origin and passing by z . For $A(\xi)$, they are arcs of circumference going from the point $+i$ to the point $-i$ through z . Finally, for the matrices $N(\nu)$ the orbits are circumferences passing through the point $+i$ and joining the points z and $-z^*$.

VI. TRACE CRITERION FOR CLASSIFICATION OF MULTILAYERS

To go beyond this geometrical picture of multilayers, let us introduce the following classification: a matrix is of type K when $[\text{Tr}(\mathbf{M}_{as})]^2 < 4$, is of type A when $[\text{Tr}(\mathbf{M}_{as})]^2 > 4$, and finally is of type N when $[\text{Tr}(\mathbf{M}_{as})]^2 = 4$. To gain insight into this classification, let us also introduce the fixed points [28] of a transfer matrix as the points in the complex plane that are invariant under the action of $\mathbf{M}_{as}$; i.e.,

$$z = \Phi[\mathbf{M}_{as}, z], \quad (18)$$

whose solutions are

$$z = \frac{-i\text{Im}(\alpha) \pm \sqrt{[\text{Re}(\alpha)]^2 - 1}}{\beta}. \quad (19)$$

Since we have

$$\text{Tr}(\mathbf{M}_{as}) = 2\text{Re}(\alpha) = \frac{2\cos\tau}{|T_{as}|}, \quad (20)$$

one can easily check that the matrices of type K have two fixed points, one inside and other outside the unit disk, both related by an inversion; the matrices of type A have two fixed points both on the boundary of the unit disk and, finally, the matrices of type N have only one (double) fixed point on the boundary of the unit disk.

Now the origin of the notation for these types of matrices should be clear: if one consider the Iwasawa decomposition (7), one can see that the matrices $\mathbf{K}(\phi)$ are of type K with the origin as the fixed point in the unit disk, matrices $\mathbf{A}(\xi)$ are of type A with fixed points $+i$

and $-i$ and matrices $\mathbf{N}(\nu)$ are of type N with the double fixed point $+i$. Of course, this is in agreement with the orbits shown in Fig. 2.

To proceed further let us note that by taking the conjugate of $\mathbf{M}_{as}$ with any matrix $\mathbf{C} \in SU(1,1)$ we obtain another multilayer matrix; i.e.,

$$\hat{\mathbf{M}}_{as} = \mathbf{C} \mathbf{M}_{as} \mathbf{C}^{-1}, \quad (21)$$

such that $\text{Tr}(\hat{\mathbf{M}}_{as}) = \text{Tr}(\mathbf{M}_{as})$. The fixed points of $\hat{\mathbf{M}}_{as}$ are then the image by $\mathbf{C}$ of the fixed points of $\mathbf{M}_{as}$. If we write the matrix $\mathbf{C}$ as

$$\mathbf{C} = \begin{bmatrix} \mathbf{c}_1 & \mathbf{c}_2 \\ \mathbf{c}_2^* & \mathbf{c}_1^* \end{bmatrix}, \quad (22)$$

the matrix elements of $\hat{\mathbf{M}}_{as}$ (denoted by carets) and those of $\mathbf{M}_{as}$ are related by

$$\hat{\alpha} = \alpha|\mathbf{c}_1|^2 - \alpha^*|\mathbf{c}_2|^2 - 2i\text{Im}(\beta\mathbf{c}_1\mathbf{c}_2^*), \quad (23)$$

$$\hat{\beta} = \beta\mathbf{c}_1^2 - \beta^*\mathbf{c}_2^2 - 2i\mathbf{c}_1\mathbf{c}_2\text{Im}(\alpha).$$

For our classification viewpoint it is essential to remark that if a multilayer has a transfer matrix of type K , A , or N , one can always find a family of matrices $\mathbf{C}$ such that $\hat{\mathbf{M}}_{as}$ in Eq. (21) is just a matrix $\mathbf{K}(\phi)$, $\mathbf{A}(\xi)$, or $\mathbf{N}(\nu)$, respectively. The explicit construction of this family of matrices is easy: it suffices to impose that $\mathbf{C}$ transforms the fixed points of $\mathbf{M}_{as}$ into the corresponding fixed points of $\mathbf{K}(\phi)$, $\mathbf{A}(\xi)$, or $\mathbf{N}(\nu)$. By way of example, let us consider the case when $\mathbf{M}_{as}$ is of type K and its fixed point inside the unit disk is z_f . Then, one should have

$$\Phi[\mathbf{C}\mathbf{M}_{as}\mathbf{C}^{-1}, 0] = \Phi[\mathbf{C}\mathbf{M}_{as}, z_f] = \Phi[\mathbf{C}, z_f] = 0. \quad (24)$$

Solving this equation one gets directly

$$\mathbf{c}_1 = \frac{1}{\sqrt{1-|z_f|^2}} \exp(i\delta), \quad \mathbf{c}_2 = -\mathbf{c}_1 z_f^*, \quad (25)$$

where δ is a real free parameter. The same procedure applies to the other two cases.

Since the matrix $\hat{\mathbf{M}}_{as}$ belongs to one of the subgroups $\mathbf{K}(\phi)$, $\mathbf{A}(\xi)$, or $\mathbf{N}(\nu)$ of the Iwasawa decomposition, and all these subgroups are, in our special case, Abelian and uniparametric, we have that

$$\hat{\mathbf{M}}_{as}(\mu_1)\hat{\mathbf{M}}_{as}(\mu_2) = \hat{\mathbf{M}}_{as}(\mu_1 + \mu_2), \quad (26)$$

where μ represent the adequate parameter ϕ , ξ , or ν . Therefore, when dealing with a periodic layered system, whose matrix is obtained as the N th power of the basic period, we have

$$\mathbf{M}_{as}^N = \mathbf{C}^{-1}\hat{\mathbf{M}}_{as}^N(\mu)\mathbf{C} = \mathbf{C}^{-1}\hat{\mathbf{M}}_{as}(N\mu)\mathbf{C}, \quad (27)$$

where $\mathbf{M}_{as}$ is now the matrix of the basic period. This is a remarkable result [29], and our procedure highlights

that it does not depend on the explicit form of the basic period.

We wish to point out that the trace criterion has been previously introduced [30, 31] to treat the light propagation in periodic structures. In fact, in that approach the values of the trace separate the band-stop from the band-pass regions of a period stratification.

Finally, in order to broaden the physical picture of this classification, let us transform Eq. (2) by the unitary matrix

$$\mathcal{U} = \frac{1}{\sqrt{2}} \begin{bmatrix} 1 & i \\ i & 1 \end{bmatrix}. \quad (28)$$

Then, we can rewrite it alternatively as

$$\mathcal{E}_a = \mathcal{M}_{as} \mathcal{E}_s, \quad (29)$$

where the new field vectors $\mathcal{E}$ and the new multilayer matrix $\mathcal{M}_{as}$ are obtained by conjugation by $\mathcal{U}$.

One can easily check that $\det \mathcal{M}_{as} = +1$ and all its elements are real numbers. Therefore, $\mathcal{M}_{as}$ belongs to the group $SL(2, \mathbb{R})$ that underlies the structure of the celebrated $ABCD$ law in first-order optics [32, 33, 34, 35].

By transforming by $\mathcal{U}$ the Iwasawa decomposition (7), we get the corresponding one for $SL(2, \mathbb{R})$, which has been previously worked out [36]:

$$\mathcal{M}_{as} = \mathcal{K}(\phi) \mathcal{A}(\xi) \mathcal{N}(\nu), \quad (30)$$

where

$$\begin{aligned} \mathcal{K}(\phi) &= \begin{bmatrix} \cos(\phi/2) & \sin(\phi/2) \\ -\sin(\phi/2) & \cos(\phi/2) \end{bmatrix}, \\ \mathcal{A}(\xi) &= \begin{bmatrix} \exp(\xi/2) & 0 \\ 0 & \exp(-\xi/2) \end{bmatrix}, \\ \mathcal{N}(\nu) &= \begin{bmatrix} 1 & 0 \\ \nu & 1 \end{bmatrix}. \end{aligned} \quad (31)$$

The physical action of these matrices is clear. Let us consider all of them as $ABCD$ matrices in geometrical optics that apply to position $\mathbf{x}$ and momentum $\mathbf{p}$ (direction) coordinates of a ray in a transverse plane. These are the natural phase-space variables of ray optics. Then $\mathcal{K}(\phi)$ would represent a rotation in these variables, $\mathcal{A}(\xi)$ a magnifier that scales $\mathbf{x}$ up to the factor $m = \exp(\xi/2)$ and $\mathbf{p}$ down by the same factor, and $\mathcal{N}(\nu)$ the action of a lens of power ν [34].

In the multilayer picture, $\mathcal{E}^{(+)}$ can be seen as the corresponding $\mathbf{x}$, while $\mathcal{E}^{(-)}$ can be seen as the corresponding $\mathbf{p}$. Then, the key result of this discussion is that when the multilayer transfer matrix has $[\text{Tr}(\mathcal{M}_{as})]^2$ lesser than, greater than or equal to 4 one can find in a direct way a family of matrices that gives a new vector basis such that the action of the multilayer, when viewed in such a basis, is exclusively rotationlike, or magnifierlike, or lenslike [15].

VII. SIMPLE EXAMPLES AND CONCLUDING REMARKS

It seems pertinent to conclude by showing how our approach works in some practical examples. Perhaps, the best way of starting is to consider the simplest layered structure one can imagine: a single film sandwiched between the same ambient and substrate media. In spite of its simplicity, it contains the essential physical ingredients of multilayer optics.

In consequence, we consider a single transparent film (medium 1) of refractive index n_1 and thickness d_1 embedded in air (medium 0). For this system we have [10]

$$T_{as} \equiv T_{010} = \frac{(1 - r_{01}^2) \exp(-i\beta_1)}{1 - r_{01}^2 \exp(-i2\beta_1)}, \quad (32)$$

where r_{01} is the Fresnel reflection coefficient at the interface 01 and $\beta_1 = (2\pi n_1 d_1 \cos \theta_1)/\lambda$ is the plate phase thickness (here λ is the wavelength *in vacuo* of the incident light and θ_1 is the refraction angle). Accordingly, we get

$$[\text{Tr}(\mathcal{M}_{010})]^2 = 4 \cos^2 \beta_1 \leq 4, \quad (33)$$

and the equality holds only in resonance conditions; i.e., when $|T_{010}| = |\cos \beta_1| = 1$. In consequence, the matrix of a single film is always of type K .

Let us consider now two films (1 and 2) described by the matrices $\mathcal{M}_{010}$ and $\mathcal{M}_{020}$, respectively. The compound system obtained by putting them together is described by the product of these matrices $\mathcal{M}_{010} \mathcal{M}_{020}$ [4, 6, 10]. In conclusion, since any layered stack can be viewed as the composition of single films, this shows that any multilayer matrix is generated by the product of matrices of type K . Take into account that the product of two matrices of type K (or A or N) can have trace lesser than, greater than or equal to 4.

On the other hand, as we have stated at the end of Section 3, to get a pure matrix $\mathcal{A}(\xi)$ one should consider a Fabry-Perot-like system formed by two identical plates (each one of them with phase thickness β_1) separated by a spacer of air with phase thickness β_2 . If we take as initial condition that in the substrate $z_s = 0.4 \exp(-i\pi/3)$, then a standard calculation gives T_{as} and R_{as} , and from them we obtain the value $z_a = -0.44 + 0.49i$, with the parameters indicated in Fig. 3. Obviously, from these (experimental) data alone we cannot infer at all the possible path for this discrete transformation.

However, the Iwasawa decomposition remedies this serious drawback: from the geometrical meaning discussed before, and once we know the values of ϕ , ξ , and ν [that are easily computed from Eqs. (9)] we get, by the ordered application of the matrices $\mathcal{K}(\phi)$, $\mathcal{A}(\xi)$, and $\mathcal{N}(\nu)$, that the trajectory from z_s to z_a is well defined through the corresponding orbits, as shown in Fig. 3.

Moreover, and this is the important moral we wish to extract from this simple example, if in some experiment the values of z_s and z_a are measured, one can find, no

matter how complicated the multilayer is, in a unique way, the three arcs of orbits that connect the initial and final points in the unit disk.

In Fig. 4 we have plotted the values of the parameters ϕ , ξ , and ν for this system when β_2 is varied between 0 and π . We have also plotted the values of $[\text{Tr}(\mathbf{M}_{as})]^2$. It is evident that the system can be of every type depending on the value of β_2 . The marked points determine special behaviors in agreement with Eq. (11) for symmetrical systems: for the left one, $\phi = \nu = 0$ and the system is represented by a pure matrix $\mathbf{A}(\xi)$; in the right one, $\xi = \nu = 0$ and then it is represented by a matrix $\mathbf{K}(\phi)$; i.e., it is antireflection stack with $T_{as} = \exp(-i\phi/2)$. Note that this system can never be represented by a matrix $\mathbf{N}(\nu)$, because it is symmetric.

To show the characteristic properties of an asymmetric system, we consider, as indicated in Section 3, the simplest one constituted by a two-layer stack made of a glass

plate (with phase thickness β_1) coated with a film of zinc sulphide (with phase thickness β_2). In Fig. 5 we have plotted the values of ϕ , ξ , and ν , as well as $[\text{Tr}(\mathbf{M}_{as})]^2$, when β_1 is fixed and β_2 is varied between 0 and π . From our previous analysis it is clear that only in the marked point we have $\phi = \xi = 0$ and $[\text{Tr}(\mathbf{M}_{as})]^2 = 4$, so the system is represented by a pure matrix $\mathbf{N}(\nu)$. Contrary to the previous example, this system can never be represented by a matrix $\mathbf{A}(\xi)$, because it is asymmetric.

In summary, we expect that the geometrical scenario presented here could provide an appropriate tool for analyzing and classifying multilayer performance in an elegant and concise way that, additionally, could be closely related to other fields of physics.

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FIG. 1: Wave vectors of the input [$E_a^{(+)}$ and $E_s^{(-)}$] and output [$E_a^{(-)}$ and $E_s^{(+)}$] fields in a multilayer sandwiched between two identical semi-infinite ambient and substrate media.

FIG. 2: Plot of several orbits in the unit disk of the elements of the Iwasawa decomposition $K(\phi)$, $A(\xi)$, and $N(\nu)$ for the group of multilayer transfer matrices.

FIG. 3: Geometrical representation in the unit disk of the action of a symmetric system made up of two identical plates ($n_1 = 1.7$, $d_1 = 1$ mm, $\theta_0 = \pi/4$, $\lambda = 0.6888$ μm and s -polarized light) separated by a spacer of phase thickness $\beta_2 = 3$ rad. The point $z_s = 0.4 \exp(-i\pi/3)$ is transformed by the system into the point $z_a = -0.44 + 0.49i$. We indicate the three orbits given by the Iwasawa decomposition and, as a thick line, the trajectory associated to the multilayer action.

FIG. 4: Plot of the values of $[\text{Tr}(\mathbf{M}_{as})]^2$ and of the parameters ϕ , ξ , and ν in the Iwasawa decomposition for the same system as in Fig. 3, as a function of β_2 .

FIG. 5: Same plot as in Fig. 4 but for an asymmetric system made up of a glass plate ($n_1 = 1.5$ and $\beta_1 = 2.75$ rad) coated with a zinc sulphide film ($n_2 = 2.3$).

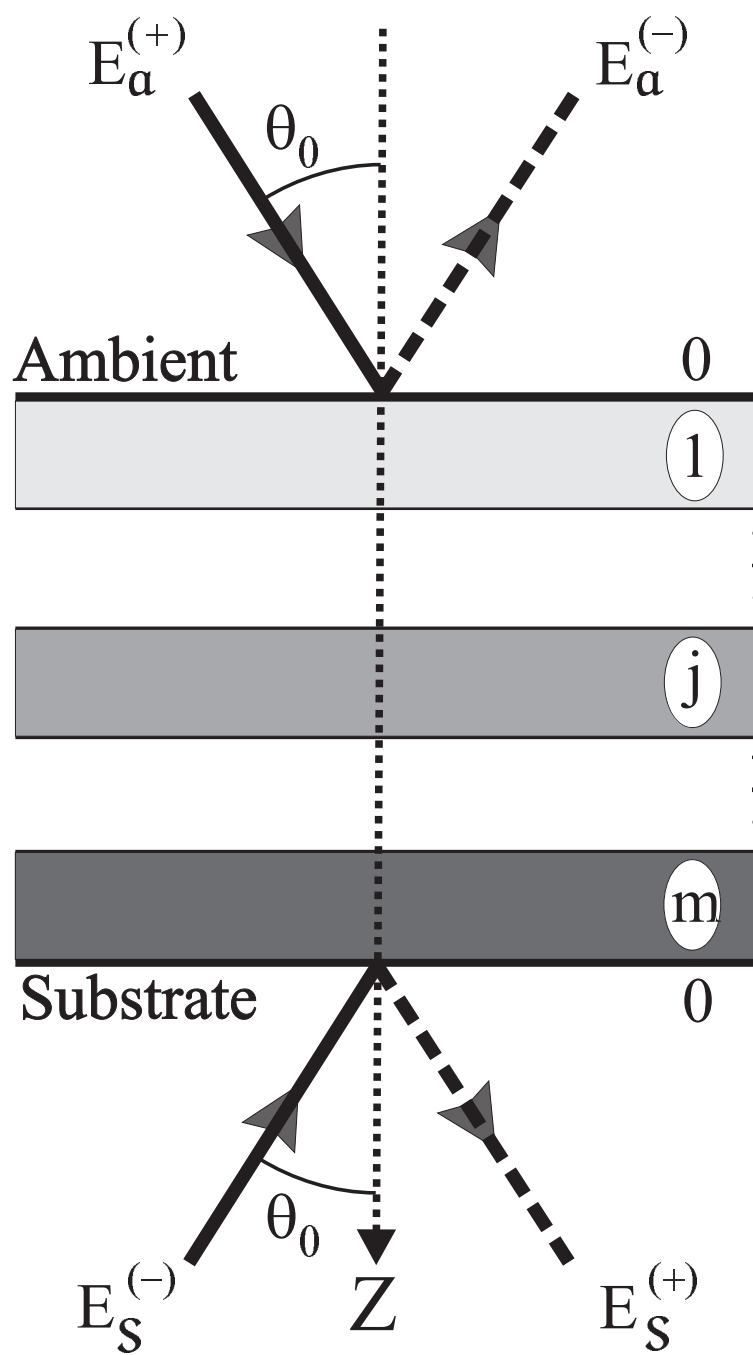
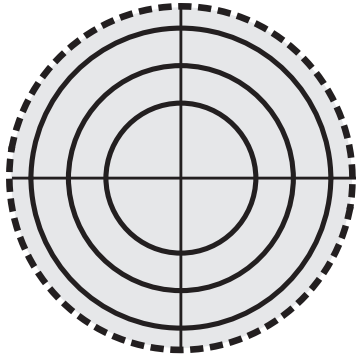
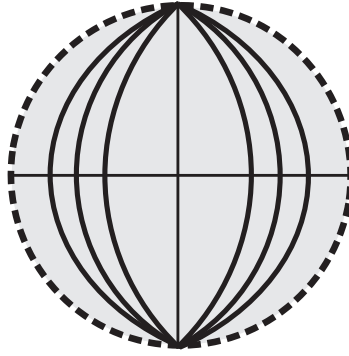


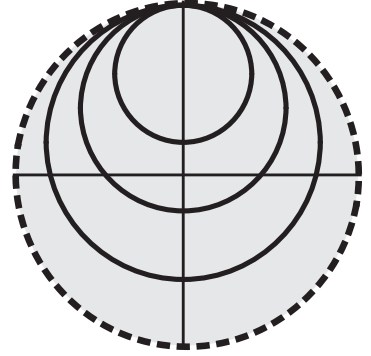
Figure 1



K



A



N

Figure 2

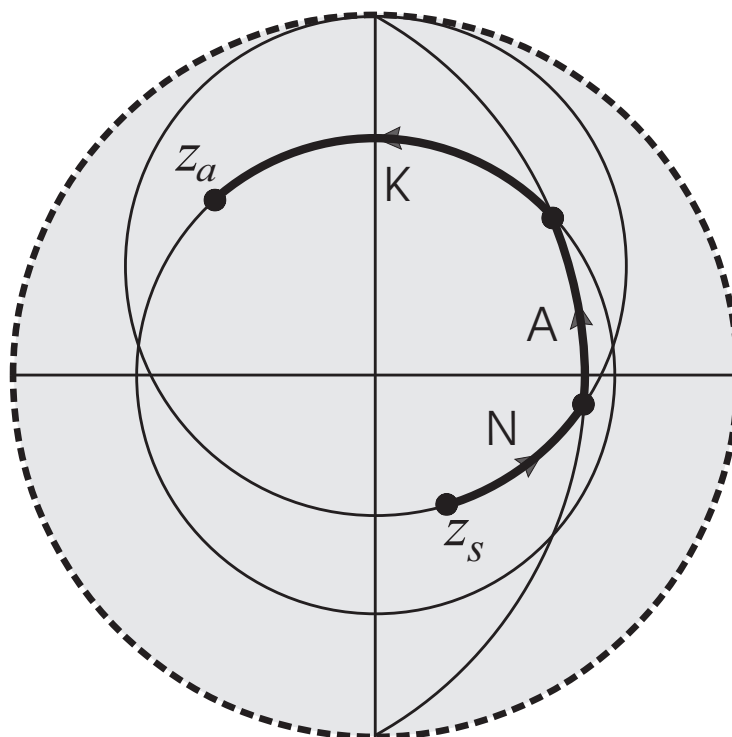


Figure 3

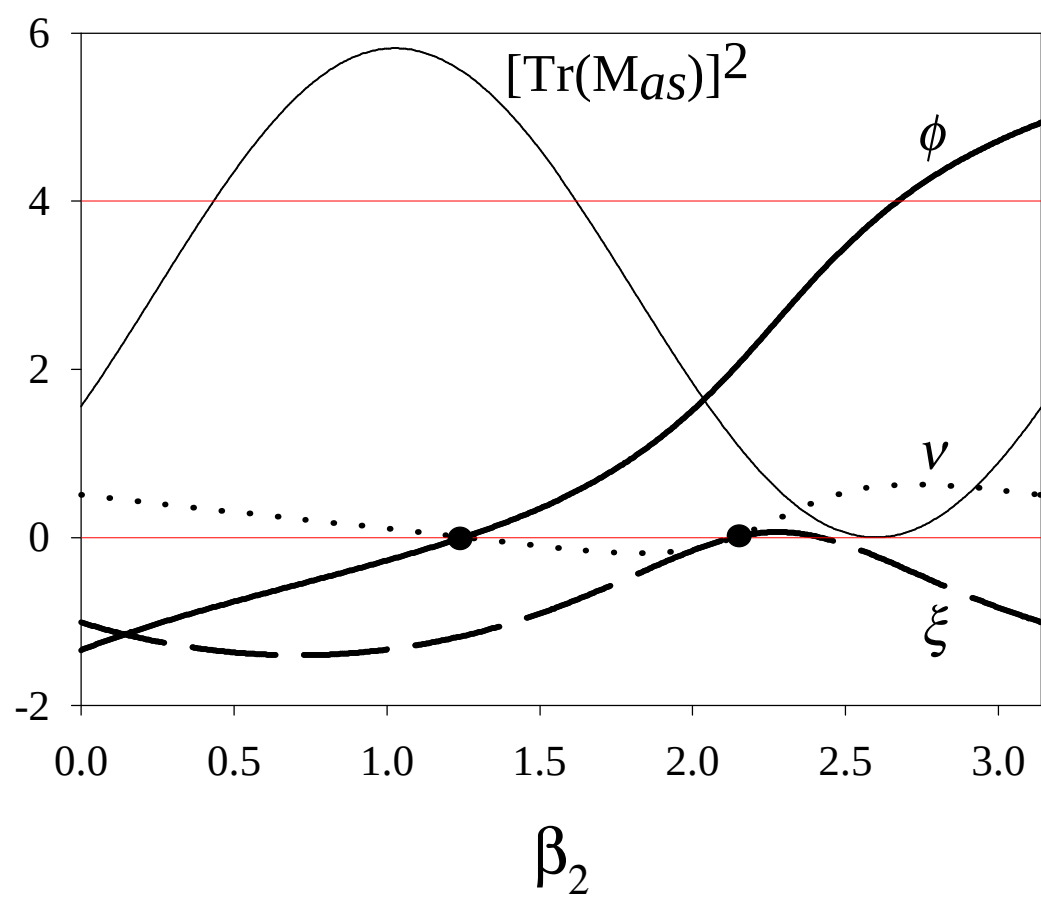


Figure 4

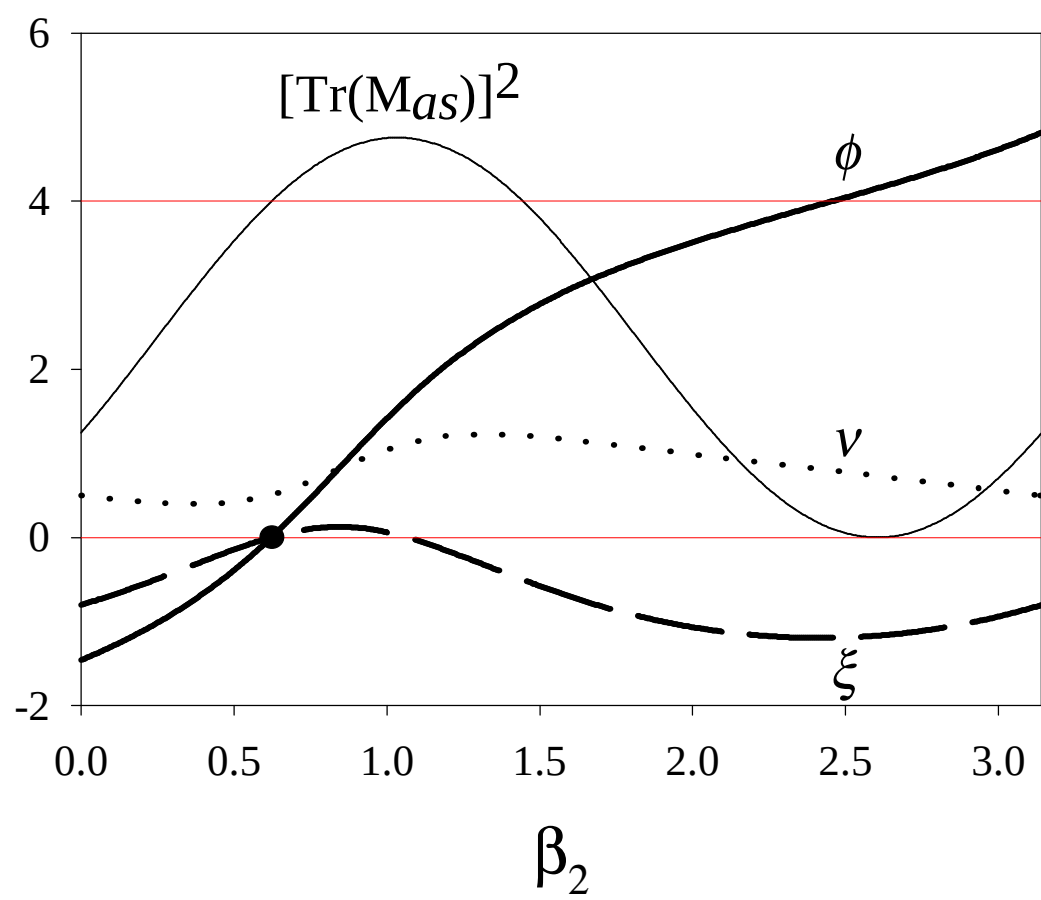


Figure 5